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**Achieving enhanced DSSC performance by microwave plasma incorporation of carbon into  
TiO<sub>2</sub> photoelectrodes**

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## Abstract

The photoactivity of carbon-incorporated titanium dioxide ( $\text{TiO}_2$ ) has been widely reported. This study involves a novel approach to the incorporation of carbon into  $\text{TiO}_2$  through the use of microwave plasma processing. The process involved thermally treating printed  $\text{TiO}_2$  nanoparticle coatings in a microwave-induced argon-oxygen plasma containing low concentrations of methane. The resulting deposited carbon layer was characterized using XRD, XPS, Raman, UV-VIS, ellipsometry, and optical profilometry. It was found that methane gas had been dissociated in the microwave plasma into carbon species, which were then deposited as a nm-thick layer onto the  $\text{TiO}_2$  coatings, most likely in the form of graphite. The photovoltaic performances of both the  $\text{TiO}_2$  and the carbon-incorporated  $\text{TiO}_2$  were assessed through  $J$ - $V$  and IPCE measurements of the N719-sensitized solar cells using the titania as their photoanodes. Up to a 72% improvement in the maximum power density ( $P_{d-max}$ ) was observed for the carbon-incorporated  $\text{TiO}_2$  samples as compared to the  $\text{TiO}_2$ , onto which no carbon was added. This improvement was found to be mainly associated with an increase in the short-circuit current density ( $J_{sc}$ ), but independent from the open-circuit voltage ( $V_{oc}$ ), the filter factor ( $FF$ ), and the level of dye adsorption. Possible contributory factors to the improved performance of the carbon-incorporated  $\text{TiO}_2$  were the enhanced electron conductivity and electron lifetime, both of which were elucidated through electrochemical impedance spectroscopy (EIS). When the surface layer was examined using XPS, the optimal carbon content on the  $\text{TiO}_2$  coating surface was found to be 8.4%, beyond which there was a reduction in the DSSC efficiency.

Key words: microwave plasma, carbon incorporation, titanium dioxide, dye-sensitized solar cells

## 1. Introduction

Dye-sensitized solar cells (DSSCs) have attracted considerable attention as a promising alternative to traditional silicon-based solar cells due to their low fabrication costs and yet relatively high solar energy conversion efficiency even in diffuse light [1-4]. There has been a large number of reports on techniques that can enhance both DSSC efficiency and stability; one method of which is to introduce novel materials as charge carriers into the cells to facilitate the photogenerated charge transport, therefore overcoming charge recombination [5-10]. Among such materials, various carbon structures have recently been investigated owing to their high electrical conductivity and hence ability to reduce the charge transfer resistance within the cells, thus improving the overall charge transfer efficiency. Tsai et al. spin-coated graphene-TiO<sub>2</sub> composite pastes onto ITO to use as the photoanodes in DSSCs and reported a 15% improvement in the cell efficiency [11]. Using a modified Hummers method followed by chemical reducing and annealing, Yang et al. introduced graphene as 2D-bridges into the TiO<sub>2</sub> photoanodes, leading to faster electron transport and lower recombination; this yielded a 39% increase in the efficiency of their DSSCs [12]. In another work, Jang et al. fabricated ordered arrays of TiO<sub>2</sub> dots embedded in carbon matrix via UV-stabilization of polystyrene-*block*-poly(4-vinylpyridine) films containing TiO<sub>2</sub> precursors followed by direct carbonization [13]. They then applied these graphite-TiO<sub>2</sub> thin films onto the external surface of TiO<sub>2</sub>-coated photoanodes and observed a 40.6% increase in the power conversion efficiency of the resulting DSSCs. In this paper, the use of a microwave plasma as a processing technique for incorporating carbon into TiO<sub>2</sub> nanoparticle photoanodes is evaluated for the first time. The process involved thermally treating printed TiO<sub>2</sub> coatings in a microwave-induced argon-oxygen plasma containing low concentrations of methane. Methane has been widely reported as a precursor for the plasma deposition of diamond

and graphitic films [14-16]. Microwave (MW) plasmas have also been used previously for the sintering of metal oxide nanoparticles such as NiO<sub>x</sub> and TiO<sub>2</sub> for use in solar devices [17, 18]. The MW-induced argon-oxygen plasma treatments were demonstrated to be both more time- and energy-efficient compared with conventional furnace sintering. When used as the photoanodes in DSSCs, the resulting sintered nanoparticle coatings were also found to have better photovoltaic performance, as the MW plasma sintering promotes better interface adhesion between the coatings and the substrates.

## **2. Experimental procedures**

*2.1. Screen-printing of TiO<sub>2</sub> photoanodes* – Fluorine-doped tin oxide (FTO) glass slides supplied by Pilkington Glass were used as the conducting substrates. They were first ultrasonically cleaned in isopropanol for 15 min and then dried in an oven at 150 °C for a further 15 min. The FTO glass substrates were subsequently immersed in a solution of 40 mM titanium tetrachloride (TiCl<sub>4</sub>) in de-ionized water for 30 min at 70 °C, so as to deposit a thin compact layer of TiO<sub>2</sub> onto FTO [19-23]. The substrates were then dried in an oven for another 30 min. A deposition paste was supplied by Dyesol, comprising of TiO<sub>2</sub> nanoparticles of size ~ 20 nm suspended in a dispersion medium. An absorption layer of ~ 3 μm (1 pass) was deposited onto the FTO glass substrates by a Digitek screen-printer using this paste. The printed glass slides were then placed in a drying box for 15 min. Another deposition paste was obtained from Dyesol, comprising of TiO<sub>2</sub> nanoparticles of size ~ 400 nm suspended in a dispersion medium. A scattering layer of ~ 6 μm (2 passes) was screen-printed on top of the absorbing layer using this paste. The printed glass slides were finally cut into small 2 x 3 cm<sup>2</sup> working electrodes that contained 1 x 1 cm<sup>2</sup> of TiO<sub>2</sub> prints.

**2.2. Microwave plasma processing and DSSC assembly** – The TiO<sub>2</sub>-coated FTO glass substrates were thermally treated using a circumferential antenna plasma (CAP) MW (2.45 GHz) system, which has been described elsewhere [24-26]. The chamber was first pumped down to 8 Pa at which point 10 sccm of oxygen (99.9%) and 50 sccm of argon (99.998%) were introduced into the chamber. The total gas pressure was then adjusted to 800 Pa using a manual throttle valve and a microwave discharge was ignited to form a plasma ball around the samples located in the center of the chamber. Substrate temperatures were monitored using a LASCON QP003 two-color pyrometer from Dr. Mergenthaler GmbH & Co. Input powers of 2.4 kW were provided from a Mugge microwave power supply. The samples were treated at 550 °C for 15 min; these were the plasma gas conditions used for sintering TiO<sub>2</sub>. The incorporation of carbon into the TiO<sub>2</sub> was achieved by introducing a low concentration of methane (99.995%) into the argon-oxygen gas mixture during the sintering process. A methane flow rate in the range of 0.5 to 3.5 sccm was investigated and the chamber pressure was maintained at 800 Pa. Both the TiO<sub>2</sub> prints sintered with and without the addition of methane were then sensitized with 0.3 mM N719 dye in a 99.8% ethanol solution for 24 hours. The DSSCs were finally assembled using the prepared TiO<sub>2</sub> as their photoanodes and platinum-coated FTO glasses as their photocathodes with an iodide/tri-iodide-based solution as the electrolyte.

**2.3. Characterization techniques** – The crystalline phase composition of the samples was examined by a Siemens D500 X-ray diffractometer (XRD) operating at 40 kV and 30 mA with Cu K $\alpha$  radiation at a wavelength of 0.1542 nm. The scan was in 2 $\theta$  mode and spanned from 20° to 70° with steps of 0.02° per second. X-ray photoelectron spectroscopy (XPS) analysis of the samples was carried out using a Kratos AXIS 165 spectrometer with a monochromatic Al K $\alpha$  radiation ( $h\nu = 1486.58$  eV). The print thickness was obtained through step height measurements

using a WYKO NT1100 optical profilometer in vertical scanning interferometry (VSI) mode. Room temperature micro-Raman scattering spectra were obtained using a SENTERRA dispersive Raman microscope from Bruker Optics. The samples were excited with 785 nm line of a DPSS laser, focused to  $\sim 1 \mu\text{m}$  by using microscope objective lens (x 20). Dye adsorption levels were obtained indirectly through UV-VIS measurements of desorbed dye molecules in 0.1 M NaOH. Incident monochromatic photo-to-current conversion efficiency (IPCE) performance of the photoanodes was measured by illumination with monochromatic lights in the range of 300 – 800 nm, which were attained through a monochromator and an order sorting filter. The  $J$ - $V$  characteristics of the prepared DSSCs were studied under 200 lux to stimulate diffuse indoor lighting conditions. Electron transport properties were investigated using electrochemical impedance spectroscopy (EIS) with measurements at open-circuit voltage under the illumination of one sun.

### **3. Results and discussion**

The overall objective of this study is to determine the effect of methane addition during the MW plasma sintering of  $\text{TiO}_2$  nanoparticles for use in DSSCs. This results section is divided into two parts; the first deals with the characterizations of the MW plasma-sintered  $\text{TiO}_2$  with and without the addition of methane during the sintering process. The second part presents results on the photovoltaic performance of the DSSCs fabricated using these  $\text{TiO}_2$  coatings as their photoanodes. The photovoltaic performance of the  $\text{TiO}_2$  coatings sintered with and without the presence of methane at different flow rates was compared against each other. DSSCs are particularly known for their superior performance under low and diffuse light; as a result,  $J$ - $V$  measurements were carried out under 200 lux to stimulate indoor lighting conditions instead of the commonly tested AM 1.5 illumination.

### 3.1. Characterizations of the TiO<sub>2</sub> working electrodes

Fig. 1 shows the XRD spectra of both an uncoated and a TiO<sub>2</sub>-coated FTO glass samples, which were sintered with the addition of methane (3.5 sccm) during the MW plasma treatment process. Characteristic peaks indexed in the graph correspond to anatase TiO<sub>2</sub>. Similar peaks were also found in the XRD spectra of the TiO<sub>2</sub> coatings treated with and without methane at other flow rates (0.5 – 3.0 sccm). This study indicates that the addition of methane under the plasma processing conditions used did not alter the TiO<sub>2</sub> crystalline phase composition.

The Raman spectra of coatings such as that obtained for the sample sintered in the presence of 3.5 sccm of methane (Fig. 2) also demonstrated the presence of anatase TiO<sub>2</sub> in the coatings, independently on whether they had been sintered with or without the addition of methane. In the case of the TiO<sub>2</sub> coatings sintered in the presence of methane however, there is evidence for the presence of carbon as indicated by the presence of the *D* band at approximately 1350 cm<sup>-1</sup> as shown in Fig. 3. It is important to note however that the corresponding *G* band expected for carbon structures in the range of 1580 – 1600 cm<sup>-1</sup> was extremely weak [13]. According to Ferrari et al., a high *I(D)/I(G)* intensity ratio indicates that the carbon layer has only sp<sup>2</sup>-hybridized (graphite-like) bonding and no sp<sup>3</sup>-hybridized (diamond-like) character [27]. Given that these bands were only found in the TiO<sub>2</sub> coatings which had been MW plasma-sintered in the presence of methane, it is reasonable to assume that methane had been dissociated in the MW plasma to carbon species which were then deposited onto TiO<sub>2</sub>, mostly likely in the form of graphite.

XPS analysis was carried out to investigate the effect of methane addition at different flow rates on the sintered coatings. Fig. 4 shows a typical XPS spectrum for the C1s state with

the deconvoluted peak at 284.7 eV representing C–C inorganic carbon, while the other peaks representing organic carbons [28]. This C–C peak is absent in the case of the TiO<sub>2</sub> coating that was MW plasma-sintered without the addition of methane. The coatings MW-plasma sintered in the presence of methane also had their outer layer removed by argon sputtering and the C–C peak was found to be absent in their XPS spectra as well. This indicates that the methane-deposited carbon did not diffuse significantly into the TiO<sub>2</sub> coating bulk. The corresponding percentage carbon (%C) of the coatings sintered in the presence of methane (0.5 – 3.5 sccm) is plotted in Fig. 5. As shown in this figure, the amount of deposited carbon (%C) is found to increase with increasing methane flow rates ~~in~~ used during the MW plasma sintering process. In order to determine the thickness of the carbon layer, spectroscopic ellipsometry was used. Measurements were obtained with a Woollam M-2000 variable wavelength ellipsometer on uncoated silicon substrates which had been placed in the MW plasma adjacent to the TiO<sub>2</sub> coatings. The ellipsometric data were recorded at incident angles of 65°, 70° and 75°, and the measurements were fitted to a three-phase model which consists of a Si substrate, a SiO<sub>2</sub> interfacial layer (fixed at 2 nm), and a fittable Cauchy carbon thin film. Also shown in Fig. 5, the thickness of the carbon layer on the flat silicon wafer surface was found to increase with increasing methane flow rate and a thickness of up to 7.0 nm was obtained at a methane flow rate of 3.5 sccm for the treatment time of 15 min.

### ***3.2. Photovoltaic performances of DSSCs using carbon-incorporated TiO<sub>2</sub> photoanodes***

Fig. 6 displays the maximum power densities ( $P_{d-max}$ ) of the DSSCs prepared using TiO<sub>2</sub> and carbon-incorporated TiO<sub>2</sub> photoelectrodes (6.7 – 9.7 %C prepared using 0.5 – 3.5 sccm of precursor methane accordingly). This figure demonstrates that there is an overall increase in  $P_{d-max}$  for DSSCs using carbon-incorporated TiO<sub>2</sub> photoanodes as compared to the coating sintered

in the absence of methane. Nonetheless, the value of  $P_{d-max}$  only increases with increasing carbon content, measured at the TiO<sub>2</sub> surface by XPS, up to 8.4% (prepared using 2.5 sccm of methane). Above this concentration, the maximum power density values decreased. The corresponding  $P_{d-max}$  values for the DSSCs using TiO<sub>2</sub> photoanodes sintered with and without 2.5 sccm of methane addition are 3.16 and 5.44  $\mu\text{W}/\text{cm}^2$  respectively, representing a 72% increase in the maximum power density. Such a significant enhancement in photovoltaic performance has previously been accounted for by an increase in the level of dye adsorption on TiO<sub>2</sub> [11]. In this current study however, a UV-VIS analysis indicates that there was in fact a decrease in the level of dye adsorption with an increase in the methane content used during the MW plasma sintering. Based on a desorption study [13], the concentration of loadable dyes was found to gradually decrease from  $5.38 \times 10^{-5}$  to  $4.71 \times 10^{-5}$   $\text{mM}/\text{cm}^2$  for the photoanodes that were prepared in the absence of methane and in the presence of up to 3.5 sccm of methane respectively (Fig. 6). This decrease in the dye adsorption level could be explained by an interruption of the dye loading process due to the carbon layer acting as a barrier on the surface of TiO<sub>2</sub> [13]. For TiO<sub>2</sub> layers with carbon content up to the optimal 8.4% (measured at the surface by XPS), the value of  $P_{d-max}$  increases despite the small reduction in the level of adsorbed dye. This would indicate that there was another factor whose impact was high enough to compensate for this decrease in the level of dye adsorption.

The detailed current density – voltage ( $J$ - $V$ ) responses of TiO<sub>2</sub> and the carbon-incorporated TiO<sub>2</sub> were analyzed in order to investigate the effect of the carbon layer on the electrical properties of the coatings. Whereas the open-circuit voltage ( $V_{oc}$ ) and the fill factor ( $FF$ ) remain relatively constant with varying carbon content (Fig. 7), the short-circuit current density  $J_{sc}$  is found to fluctuate (Fig. 8). Given that the shape of the curve in Fig. 8 is similar to

that of Fig. 6, which plots  $P_{d-max}$  against methane flow rate (hence carbon content), it is suggested that the observed change in  $P_{d-max}$  values are mainly associated with changes in  $J_{sc}$ . In other words,  $J_{sc}$  and hence  $P_{d-max}$  increase with increasing carbon content up to 8.4% when measured at the surface by XPS (layer thickness  $\sim 6.4$  nm) and decrease thereafter. The same trend is also reflected in the IPCE performances. As illustrated in Fig. 9, the IPCE response is maximized at the wavelengths of 335 and 530 nm. Overall the IPCE responses at these two wavelengths as well as all the other wavelengths are enhanced for the carbon-incorporated TiO<sub>2</sub>. This enhancement in IPCE is likely to be due to carbon in the form of graphite as it is a good electron carrier, which facilitates the photogenerated charge transport and suppresses the recombination and back reaction [13]. With higher carbon contents above the 8.4% measured at the surface, the excess carbon can act as a recombination center instead of providing an electron pathway, which means short circuit can happen more easily [12]. In this latter case, not only did carbon not offset the reduced level of dye adsorption at higher carbon content as previously discussed, but it also diminished  $J_{sc}$  and hence  $P_{d-max}$  as shown in Fig. 8 and 6 respectively.

To obtain a greater understanding of the effect of carbon incorporation, the charge transport properties of the coatings were evaluated using EIS measurements on the TiO<sub>2</sub> as well as the best-performing 8.4% surface carbon-incorporated TiO<sub>2</sub> coatings. Fig. 10 presents the results using Nyquist plots with the three distinctive semicircles [11, 29, 30]. The first semicircle is attributed to the impedance of the charge transfer process at the counter electrode/electrolyte interface; the second semicircle is ascribed to the impedance of the charge transfer process at the working electrode/electrolyte interface; and the third semicircle is related to the Nernstian diffusion in the electrolyte. As shown in Fig. 10, the semicircles for the 8.4% surface carbon-incorporated TiO<sub>2</sub> are smaller than those of the TiO<sub>2</sub> only photoanode. This indicates a lower

interfacial charge transfer resistance and hence a higher charge transfer efficiency. These results can also be viewed using Bode plots as shown in Figure 11, which enables information to be extracted about the electron lifetime within the photoanodes [11, 29, 30]. These plots indicated electron lifetimes of approximately 14 milliseconds for the TiO<sub>2</sub> and 33 milliseconds for the 8.4% surface carbon-incorporated TiO<sub>2</sub>. This increase is again likely to be due to the deposition of carbon in the form of graphite with its high electrical conductivity acting as carriers within the cell, thus helping to facilitate the charge transport and restraining charge recombination.

#### **4. Conclusions**

Carbon-incorporated TiO<sub>2</sub> photoanodes were successfully prepared during the sintering of TiO<sub>2</sub> coatings using a MW argon-oxygen-methane plasma. Based on XPS analysis, the deposited carbon is concentrated on the surface of the TiO<sub>2</sub> coatings and not in the bulk. The carbon-incorporated TiO<sub>2</sub> demonstrated a higher photovoltaic performance compared to the TiO<sub>2</sub> only coating, when used as photoanodes in DSSC applications. Up to a 72% increase in maximum power density  $P_{d-max}$  was observed for the optimized MW plasma treatment conditions, which based on ellipsometry measurements carried out with silicon wafer substrates had deposited a carbon layer thickness of 6.4 nm (8.4 %C measured by XPS surface analysis). This enhancement is likely to be due to carbon in the form of graphite with its superior electrical conductivity acting as a charge carrier. This would help to reduce interfacial charge transfer resistance, hence facilitating charge transport and suppressing recombination. As a result, the IPCE response and the short-circuit current density  $J_{sc}$  both increased with increasing carbon content up to the 8.4% surface level as highlighted above. At higher levels, the carbon could act as a recombination center as well as a barrier for dye adsorption, both of which led to a decrease in the maximum power density. From this study, it was concluded that the incorporation of carbon onto the surface

of the TiO<sub>2</sub> photoanodes using a microwave plasma during the nanoparticle sintering process can lead to a significant increase in DSSC efficiency.

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## Figure captions

Fig. 1: XRD spectra of an FTO glass slide (dotted line) and a TiO<sub>2</sub>-coated FTO that was sintered with the addition of methane (3.5 sccm) during the MW argon-oxygen plasma treatment.

Fig. 2: Raman spectrum in the range of 100 – 800 cm<sup>-1</sup> of the TiO<sub>2</sub> sintered with an addition of 3.5 sccm of precursor methane.

Fig. 3: Raman spectra in the range of 900 – 2400 cm<sup>-1</sup> of the TiO<sub>2</sub> sintered with and without an addition of 3.5 sccm of precursor methane.

Fig. 4: XPS spectrum of C1s state for the TiO<sub>2</sub> sintered with an addition of 3.5 sccm of precursor methane.

Fig. 5: Carbon percentage (%C) and carbon layer thickness for the carbon-incorporated TiO<sub>2</sub> prepared using precursor methane at different flow rates.

Fig. 6: Dye adsorption level and maximum power density ( $P_{d-max}$ ) measured from the prepared DSSCs as a function of the precursor methane flow rate.

Fig. 7: Open-circuit voltage ( $V_{oc}$ ) and fill factor ( $FF$ ) measured from the prepared DSSCs as a function of the methane flow rate used in their preparation.

Fig. 8: Short-circuit current density ( $J_{sc}$ ) measured from the prepared DSSCs as a function of the methane flow rate used in their preparation.

Fig. 9: IPCE responses of TiO<sub>2</sub>, 7.9% surface carbon-incorporated, 9.7% surface carbon-incorporated and the best-performing 8.4% surface carbon-incorporated TiO<sub>2</sub> under the illumination of one sun at open-circuit voltage.

Fig. 10: Nyquist plots of the EIS of TiO<sub>2</sub> and the best-performing 8.4% surface carbon-incorporated TiO<sub>2</sub>.

Fig. 11: Bode plots of the EIS of TiO<sub>2</sub> and the best-performing 8.4% surface carbon-incorporated TiO<sub>2</sub>.

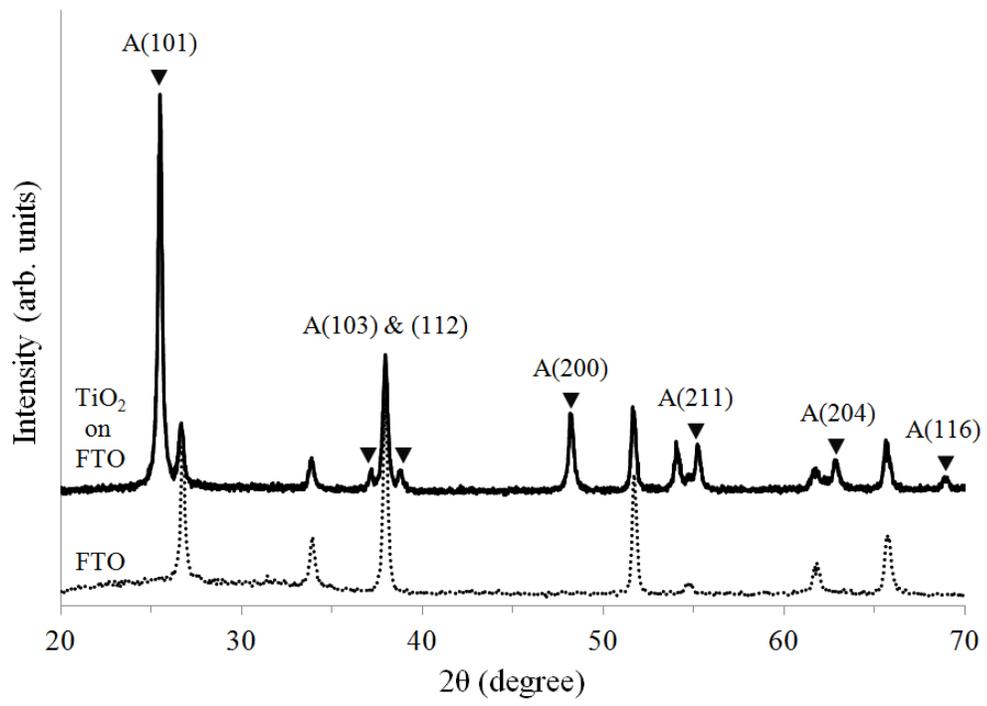


Fig. 1

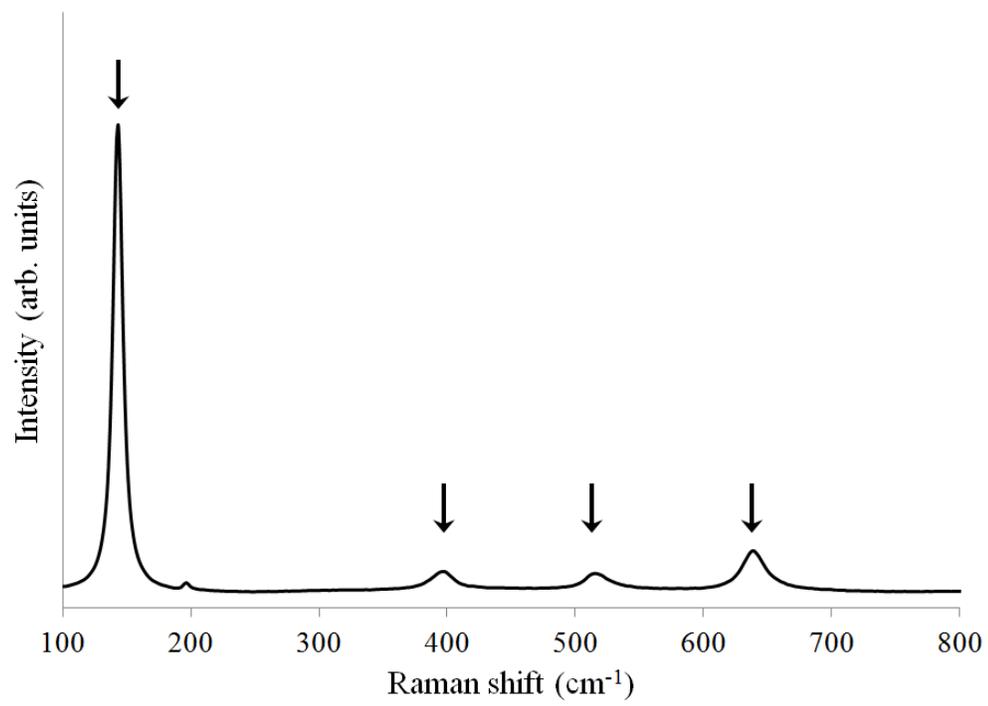


Fig. 2

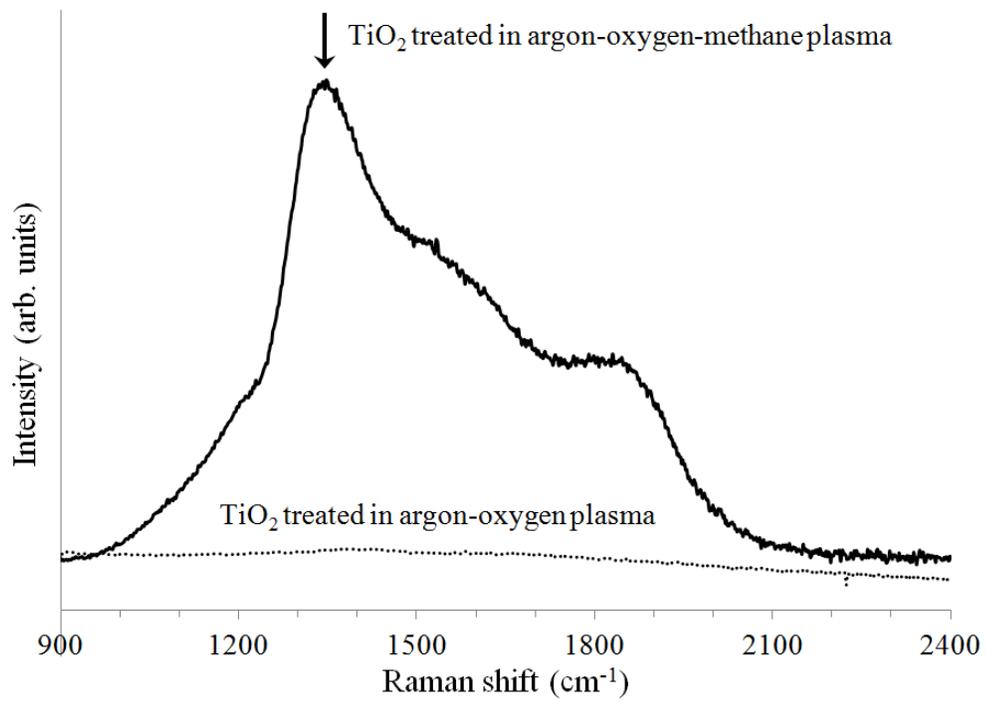


Fig. 3

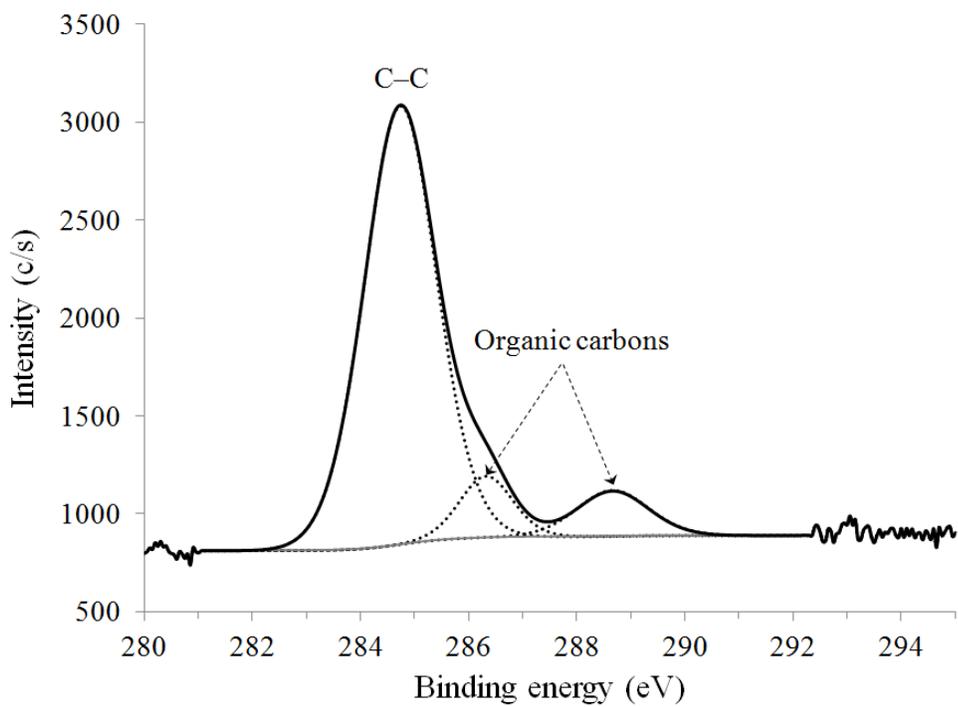


Fig. 4

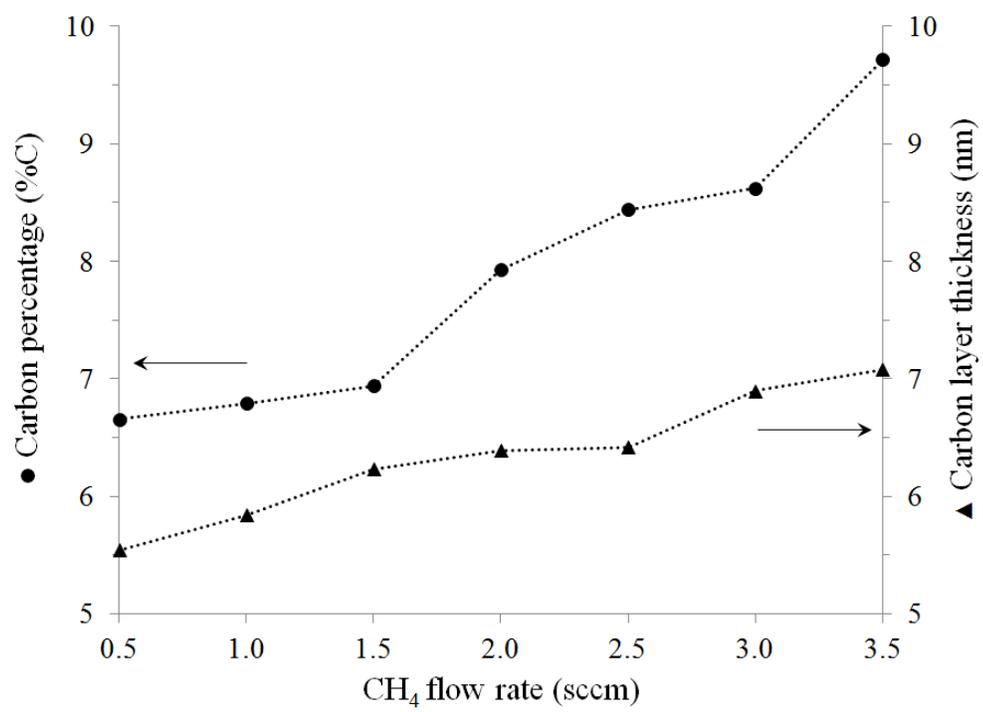


Fig. 5

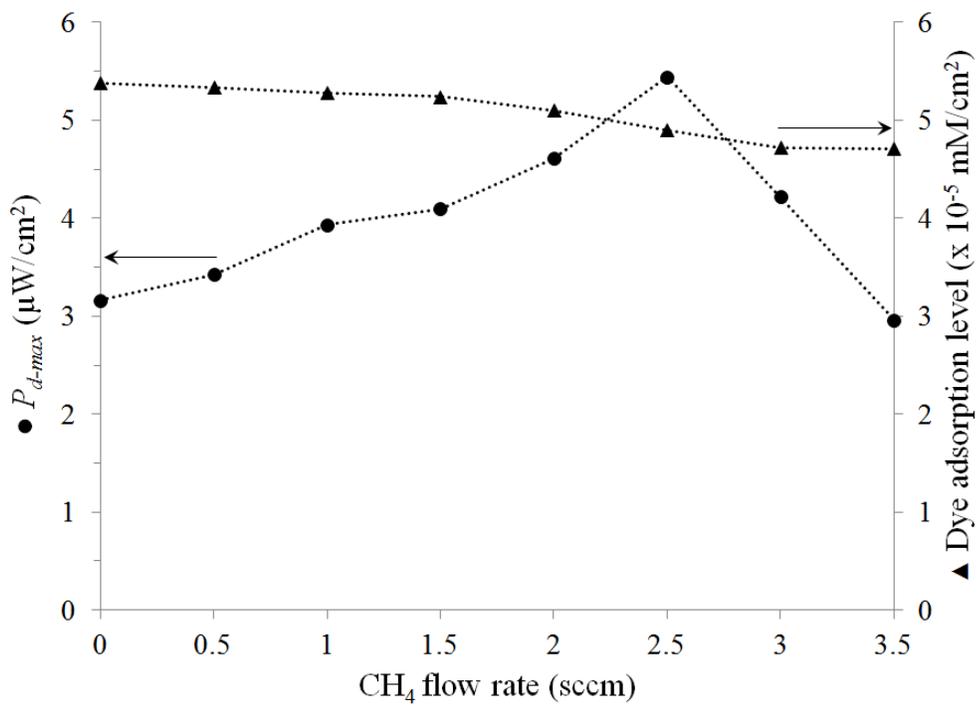


Fig. 6

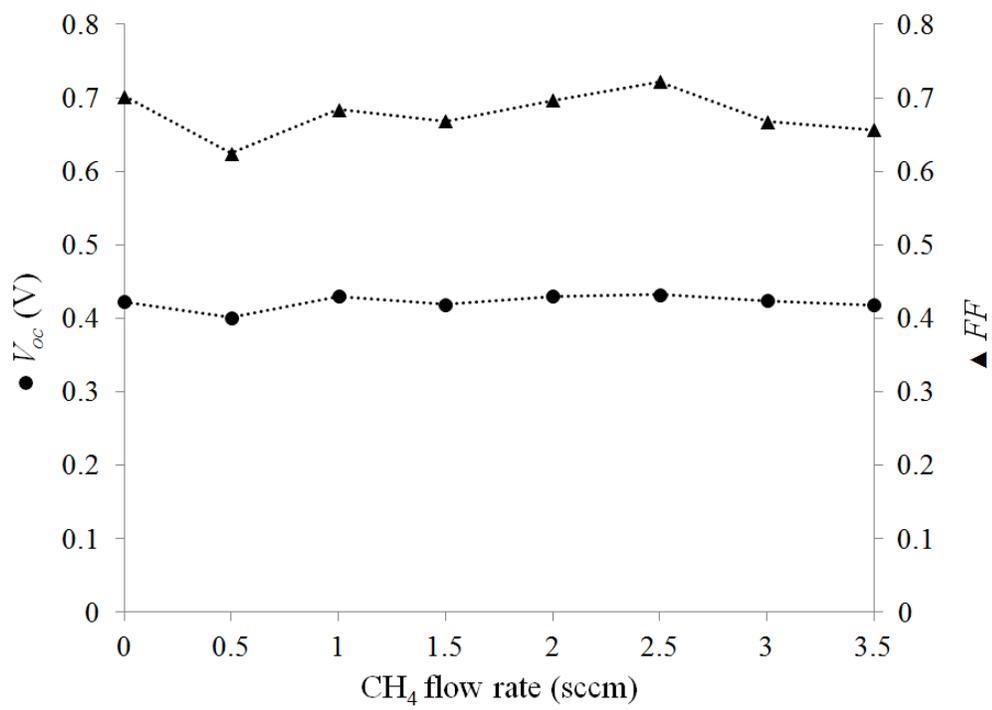


Fig. 7

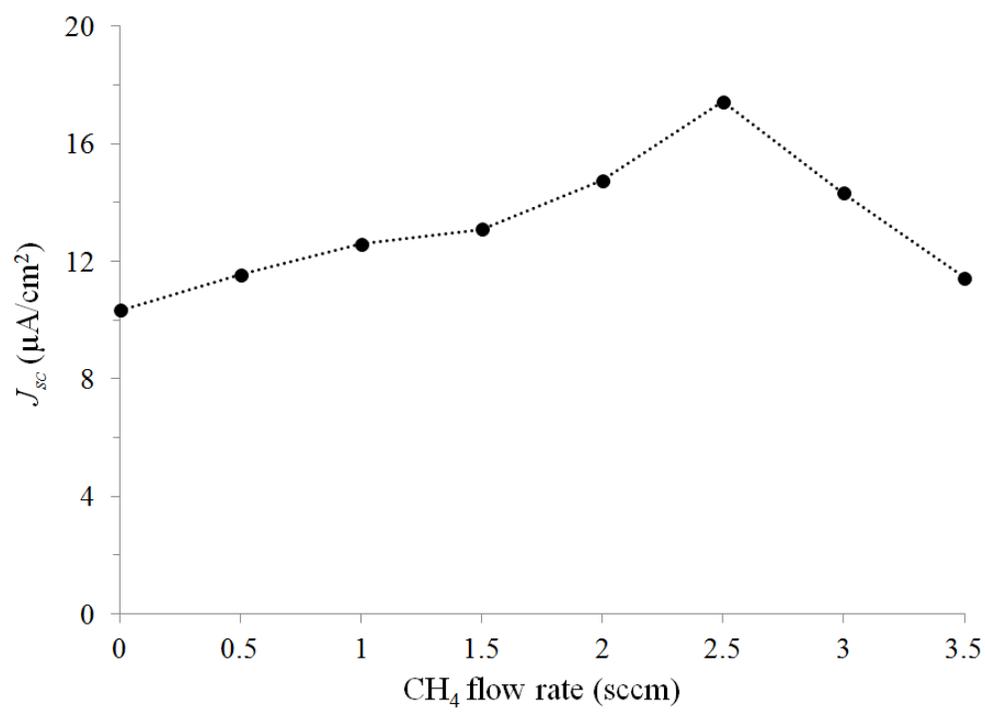


Fig. 8

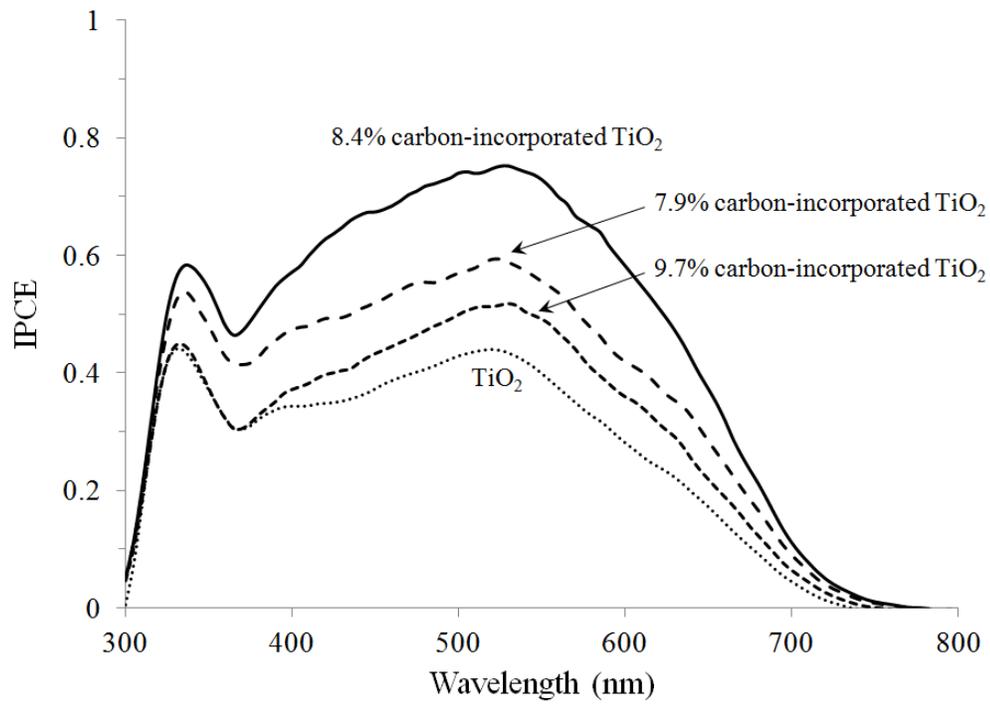


Fig. 9

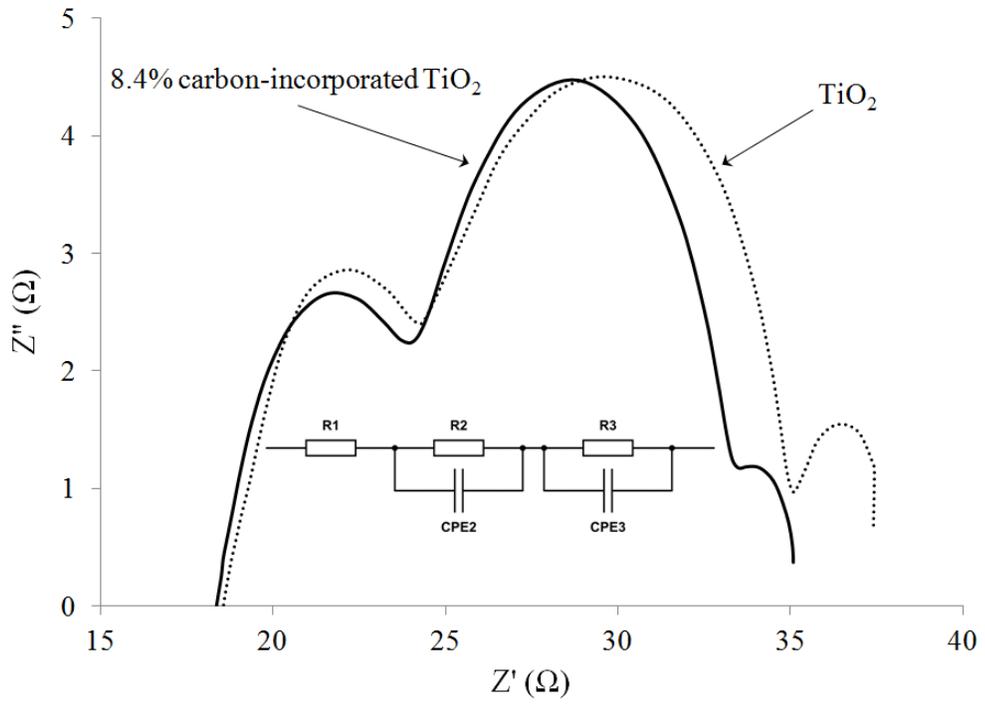


Fig. 10

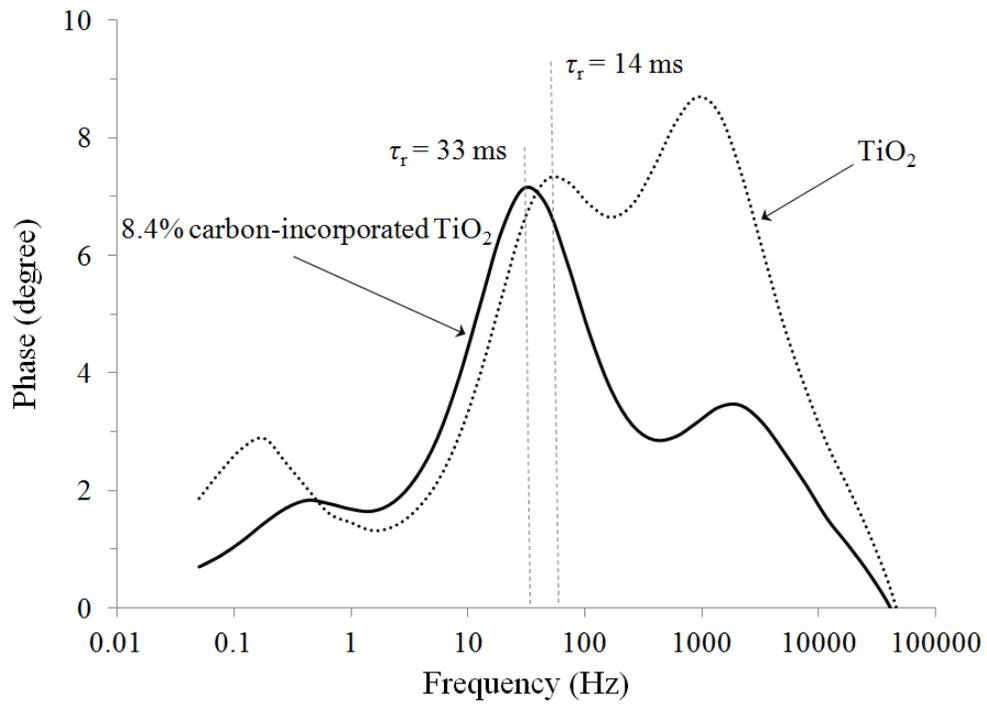


Fig. 11